

# Search Notes



Application/Control No.

10/720,311

Examiner

Kin-Chan Chen

Applicant(s)/Patent under  
Reexamination

SUN ET AL.

Art Unit

1765

## SEARCHED

Class	Subclass	Date	Examiner
438	243	8/23/2005	KCC
	244		
	245		
	700		
	702		
	703		
	704		
	706		
	712		
438	719	8/23/05	KCC

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
East keyword search USPAT, USPG-pub. Epo, JPO, IBM-TDB. Derwent.	8/23/2005	KCC
inventor search.	8/23/05	KCC